



2020.10/06 Kr(N06,S03)										条件全て書くこと												
Run Summary Sheet : CAMAC & LabView																						
Fname	start	stop	date	Header	Ender / L	Elapse	コメント	Att	10	5	3	2	Trig	Web	AuF	Kap	IC1	PL	ED	Air1	Air2	Det.Setup
2	13:38:28	13:39:33	20/10/06	scanED002 124.0 um 003050000000	ssdRun002	0:01:05		100														
3	13:39:48	13:40:48	20/10/06	scanED003 279.0 um 103400700000	ssdRun003	0:01:00																
4	13:41:03	13:42:03	20/10/06	scanED004 333.8 um 023006700000	ssdRun004	0:01:00																
5	13:42:18	13:43:22	20/10/06	scanED005 379.2 um 103450700000	ssdRun005	0:01:04																
6	13:43:38	13:45:48	20/10/06	scanED006 496.1 um 100000080000	ssdRun006	0:02:10																
7	13:46:03	13:47:03	20/10/06	scanED007 508.9 um 120000080000	ssdRun007	0:01:00																
8	13:47:18	13:48:18	20/10/06	scanED008 534.5 um 000400080000	ssdRun008	0:01:00																
9	13:48:33	13:49:38	20/10/06	scanED009 591.7 um 000050080000	ssdRun009	0:01:05																
10	13:49:53	13:50:53	20/10/06	scanED010 769.6 um 103456080000	ssdRun010	0:01:00																
11	13:51:08	13:52:08	20/10/06	scanED011 782.6 um 000050780000	ssdRun011	0:01:00																
12	13:52:23	13:53:28	20/10/06	scanED012 819.7 um 023006780000	ssdRun012	0:01:05																
13	13:53:43	13:54:43	20/10/06	scanED013 831.2 um 000450780000	ssdRun013	0:01:00																
	13:55:00			ビーム調整終了	p.166		IC1,PL,SSD HV=Onのママで架台交換															
	19:15		20/10/06	(N06)利用スタート	p.173																	
	11:10		20/10/08	(N06)利用終了			加速器ロスタイム=0min															
	11:40:00			(S03)準備開始																		
	14:01		20/10/08	(S03)利用スタート	p.174																	
	7:00		20/10/09	(S03)利用終了			加速器ロスタイム=0min															
	7:30:00			利用者片付け終了			架台交換															
	実験中：利用終了後																					
	回路チェック																					
	不要だった																					
	scnEDssd: Eスペクトル(3) 納品用																					
scnEDssd	202010090739.dat				p.184																	
	7:39:00	7:49:00	20/10/09	納品用: 7点 x 60sec		0:10:00	PL_3K_Sor 200cps_PandS	1	4	0	0	0	PandS	R38	50u	75u	O	100u	var	145	220	SSD@Air2,X=0
	ED出口ロリメータ・撤去で測定																					
scnEDssd03-																						
1	7:39:59	7:40:55	20/10/09	scanED001 0.0 um 000000000000	ssdRun001	0:00:56																
2	7:41:11	7:42:15	20/10/09	scanED002 522.5 um 023000080000	ssdRun002	0:01:04																
3	7:42:30	7:43:30	20/10/09	scanED003 795.9 um 020006780000	ssdRun003	0:01:00																
4	7:43:45	7:44:45	20/10/09	scanED004 854.2 um 120450780000	ssdRun004	0:01:00																
5	7:45:00	7:46:00	20/10/09	scanED005 397.4 um 000056700000	ssdRun005	0:01:00																
6	7:46:14	7:47:15	20/10/09	scanED006 557.5 um 120400080000	ssdRun006	0:01:01																
7	7:47:30	7:48:30	20/10/09	scanED007 609.2 um 120050080000	ssdRun007	0:01:00																
8	7:48:46	7:49:50	20/10/09	scanED008 148.8 um 000450000000	ssdRun008	0:01:04																
	PL HV (3: 利用終了後)																					
PLHV03-					p.184																	
	★Run毎にHVを分けて測定した																					
1	8:02:50	8:03:22	20/10/09	PLHV03-01 PL1=PL2=1000V	end 30sec	0:00:32	ED=0	1	4	0	0	0	PorS(0)	R38	50u	75u	O	100u	0	145	220	PL2@Air2の後ろ
2	8:04:39	8:05:22	20/10/09	PLHV03-02 800V	end	0:00:43																
3	8:06:50	8:07:32	20/10/09	PLHV03 900V	end	0:00:42																
4	8:08:54	8:09:49	20/10/09	PLHV03 1100V	end	0:00:55																
5	8:10:40	8:11:29	20/10/09	PLHV03 1200V	end HVrun	0:00:49																
	scnEDpl: PL2/PL1 透過率 (1)																					
scnEDpl	202010090816.dat				p.185		ED変化 PL1->PL2 透過率測定															
	8:16:00	8:23:00	20/10/09	ため用: 20点 x 30sec		0:07:00	PL1=100u PL2=500u	1	4	0	0	0	PorS(0)	R38	50u	75u	O	100u	var	145	220	PL2@Air2の後ろ
	★? Xpos=0でIC2入っていないか?																					
scnEDpl01-																						
1	8:16:50	8:17:25	20/10/09	scanED001 100.2 um 000050000000	ssdRun001	0:00:35																
2	8:17:41	8:18:15	20/10/09	scanED002 100.8 um 000060000000	ssdRun002	0:00:34																
3	8:18:31	8:19:05	20/10/09	scanED003 196.4 um 000000700000	ssdRun003	0:00:34																
4	8:19:21	8:19:50	20/10/09	scanED004 485.9 um 000000080000	ssdRun004	0:00:29																
5	8:20:06	8:20:40	20/10/09	scanED005 491.4 um 000000080000	ssdRun005	0:00:34																
6	8:20:56	8:21:25	20/10/09	scanED006 496.1 um 100000080000	ssdRun006	0:00:29																
7	8:21:41	8:22:10	20/10/09	scanED007 498.8 um 020000080000	ssdRun007	0:00:29																
8	8:22:26	8:23:00	20/10/09	scanED008 509.8 um 003000080000	ssdRun008	0:00:34																
9	8:23:16	8:23:53	20/10/09	scanED009 534.5 um 000400080000	ssdRun009	0:00:37																
	scnEDpl: PL2/PL1 透過率 (2)																					
scnEDpl	202010090824.dat				p.185		前回と同じ 10点セットでやり直し															
	8:24:00	8:32:00	20/10/09	毎回用: 10点 x 30sec		0:08:00	PL1 2.5K, PorS=0	1	4	0	0	0	PorS(0)	R38	50u	75u	O	100u	var	145	220	PL2@Air2の後ろ
scnEDpl02-																						
1	8:24:40	8:25:10	20/10/09	scanED001 0.0 um 000000000000	ssdRun001	0:00:30	★? Xpos=0でIC2入っていないか?															
2	8:25:25	8:25:55	20/10/09	scanED002 100.2 um 000050000000	ssdRun002	0:00:30																
3	8:26:11	8:26:45	20/10/09	scanED003 196.4 um 000000700000	ssdRun003	0:00:34																
4	8:27:01	8:27:30	20/10/09	scanED004 302.1 um 000050700000	ssdRun004	0:00:29																
5	8:27:46	8:28:20	20/10/09	scanED005 397.4 um 000056700000	ssdRun005	0:00:34																
6	8:28:36	8:29:10	20/10/09	scanED006 498.8 um 020000080000	ssdRun006	0:00:34																
7	8:29:26	8:29:55	20/10/09	scanED007 609.2 um 120050080000	ssdRun007	0:00:29																
8	8:30:11	8:30:45	20/10/09	scanED008 735.6 um 000456080000	ssdRun008	0:00:34																
9	8:31:00	8:31:30	20/10/09	scanED009 806.4 um 003050780000	ssdRun009	0:00:30																
10	8:31:46	8:32:15	20/10/09	scanED010 855.0 um 003450780000	ssdRun010	0:00:29																
11	8:45:55	8:46:10	20/10/09	scanED001 0.0 um 000000000000	itE	0:00:15																
	Gaf焼き(2)神原																					
	照射時間 vs 感光度 Krビームで測定																					
	8:45:00		20/10/09	GafHDV2 @ Z=Sample位置(Zslid=85)	IC1PL1有 ED=0																	
Gaf	sec	IC1	Flux				照射位置で確認用 ED=無し	0	3	0	0	0		R38	50u	75u	O	100u	0u	145	200	Gaf@Z=85照射位置